


<b>Search Notes</b>  	<b>Application/Control No.</b>  10710600	<b>Applicant(s)/Patent Under Reexamination</b>  FUJISAKI, IWAO
	<b>Examiner</b>  DAVID Q NGUYEN	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
455	556.1	04/21/09	DN
370	338	04/21/09	DN
455	456.1	08/12/09	DN
705	26	08/12/09	DN
340	426.1	08/12/09	DN
update search		10/14/2009	DN
update search		04/08/10	DN
455	558	04/08/10	DN
455	567	04/08/10	DN
455	410	04/08/10	DN
Update search		08/10/2010	
Update search		11/30/2010	DN

SEARCH NOTES		
Search Notes	Date	Examiner
Text search	04/21/09	DN
Text search	08/12/09	DN
Text search	10/24/2009	DN
Text search	04/08/10	DN
Text search	08/10/2010	DN
Update search	11/30/2010	DN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--